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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/826,733	04/16/2004	Masataka Shinoda	075834.00485	1364
33448 ROBERT J. DE	7590 05/16/200	EXAMINER		
LEWIS T. STE	ADMAN	GOMA, TAWFIK A		
SUITE 5450 SI	PKE, LYONS AND KI EARS TOWER	ART UNIT	PAPER NUMBER	
CHICAGO, IL	60606-6306	•	2627	
		,	MAIL DATE	DELIVERY MODE
			05/16/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

		Application No. Applicant(s)					
Office Action Summary		10/826,733		SHINODA, MASATAKA			
		Examiner		Art Unit	I		
		Tawfik Goma		2627			
The MAILING DATE of this co Period for Reply	ommunication app	ears on the cover	sheet with the co	orrespondence ad	ddress		
A SHORTENED STATUTORY PER WHICHEVER IS LONGER, FROM  - Extensions of time may be available under the pafter SIX (6) MONTHS from the mailing date of If No period for reply is specified above, the ma  - Failure to reply within the set or extended period Any reply received by the Office later than three earned patent term adjustment. See 37 CFR 1.	THE MAILING DA provisions of 37 CFR 1.13 this communication. ximum statutory period wid for reply will, by statute, months after the mailing	ATE OF THIS CO 16(a). In no event, hower rill apply and will expire cause the application to	DMMUNICATION ever, may a reply be tim SIX (6) MONTHS from to become ABANDONED	l. ely filed he mailing date of this ( ) (35 U.S.C. § 133).	,		
Status							
1) Responsive to communication	n(s) filed on 25 Jai	nuary 2007.					
2a) This action is FINAL.		action is non-fina	al.				
3) Since this application is in cor	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in accordance with the	practice under Ex	x parte Quayle,	1935 C.D. 11, 45	3 O.G. 213.			
Disposition of Claims							
4) Claim(s) <u>1,2 and 5-7</u> is/are pe	4)⊠ Claim(s) <u>1,2 and 5-7</u> is/are pending in the application.						
4a) Of the above claim(s)	4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed	<b>I</b> .						
6)⊠ Claim(s) <u>1-2 and 5-7</u> is/are re	)⊠ Claim(s) <u>1-2 and 5-7</u> is/are rejected.						
7) Claim(s) is/are objecte	Claim(s) is/are objected to.						
8) Claim(s) are subject to	restriction and/or	election require	ment.				
Application Papers							
9)☐ The specification is objected to	o by the Examiner	·.					
10)☐ The drawing(s) filed on	•		ected to by the E	xaminer.			
Applicant may not request that a							
Replacement drawing sheet(s) in					FR 1.121(d).		
11) The oath or declaration is obje	ected to by the Exa	aminer. Note the	attached Office	Action or form P	TO-152.		
Priority under 35 U.S.C. § 119							
12) ☐ Acknowledgment is made of a a) ☐ All b) ☐ Some * c) ☐ Non		priority under 35	U.S.C. § 119(a)	-(d) or (f).			
·		s have been rece	ived				
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3. ☐ Copies of the certified of					Stage		
application from the Inte	· ·	· ·			Clage		
* See the attached detailed Offic		•	,	d.			
Attachment(s)							
1) Notice of References Cited (PTO-892)		<b>4</b> \ \	Interview Summary (	PTO-413)			
2) D Notice of Draftsperson's Patent Drawing R		_	Paper No(s)/Mail Da	te			
<ol> <li>Information Disclosure Statement(s) (PTO/ Paper No(s)/Mail Date</li> </ol>	(SB/08)		Notice of Informal Pa Other:	atent Application			

## **DETAILED ACTION**

This action is in response to the Pre-Appeal Conference request filed on 1/25/2007 and the decision to reopen prosecution sent on 3/12/2007. Please see response to arguments with reference to the use of the same references in this rejection as the prior rejection.

## Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1, 2 and 5-7 are rejected under 35 U.S.C. 103(a) as being unpatentable over Knight et al (US 6243350) in view of Okubo (US 2003/0118936).

Regarding claim 1, Knight discloses an optical recording medium recorded and reproduced with irradiation of light thereon, said irradiation of light being made by an objective lens of which numerical aperture is larger than 1 to record and reproduce recorded pits (col. 35 lines 57-63, NA=NA of Objective lens (.65) x Refractive index of SIL (2) = 1.3), comprising at least a recording layer and a silicon oxide layer being formed from the light irradiation side, in that order (col. 37 line 12). Knight further discloses wherein said recording layer has formed thereon a protective layer of which refractive index is larger than a numerical aperture of said objective lens (SiN, col. 37 line 12 and lines 3-6). Although Knight discloses that the any write-once, or phase change material can be used as the recording layer, he fails to disclose a silicon recording layer. In the same field of endeavor, Okubo discloses a recording medium

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with a silicon recording layer (par. 83). It would have been obvious to one of ordinary skill in the art to use a silicon recording layer as taught by Okubo in the recording medium taught by Knight. The rationale is as follows: One of ordinary skill in the art would have been motivated to use a silicon recording layer as a suitable write-once recording material since Knight (col. 29 lines 44-67) suggests using any suitable write-once recording material and Okubo teaches that silicon is a suitable write-once material.

Regarding claim 2, Knight in view of Okubo disclose everything claimed as applied above. Further in regard to claim 2, it is known that silicon is oxidized when irradiated by a recording laser, and pits are formed by changing silicon to silicon-oxide by the recording laser.

Regarding claim 5, claim 5 is rejected for the same reasons as claims 1 and 2 above.

Regarding claims 6 and 7, Okubo discloses using a protective layer (5, fig. 4) made of Ta2O5 (par. 85). It would have been obvious to one of ordinary skill in the art at the time of the applicant's invention to modify the recording medium disclosed by Knight by substituting a protective layer made of Ta2O5 as taught by Okubo. The rationale is as follows: One of ordinary skill in the art at the time of the applicant's invention would have been motivated to provide a protective layer made of Ta2O5 as a well known protective layer material commonly used in the art. The refractive index of Ta2O5 is known to be greater than 2 for wavelengths used during recording which would be greater than the numerical aperture of the objective lens used by Knight (1.3).

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## Response to Arguments

The pre-appeal conference request resulted in the decision to reopen prosecution based on an incorrect assumption of the method of calculating the effective Numerical Aperture of a system. The applicant presented arguments which in part centered around the premise that the Numerical Aperture is calculated by adding the NA of the objective lens with the refractive index of the SIL (Silicon Immersion Lens) (see applicant's arguments page 3, 3rd paragraph continued through page 4 lines 1-2). This assertion by applicant is incorrect because it has come to the examiner's attention that the effective numerical aperture of such a system is computed by taking the product of the Numerical Aperture of the objective lens and the refractive index of the SIL (See for example, Jain US 6061322 col. 6 lines 34-42). As a result, and in view of this new evidence, Knight specifically discloses a system where the effective NA is equal to 1.3 (see col. 35 lines 57-62) and wherein a protection layer composed of SiN has a refractive index equal to 2.07 (col. 35 line 65). Therefore, this disclosure overcomes applicant's argument that the examiner has combined a broad teaching of NA greater than 1, with a specific disclosure of the refractive index of the index of refraction. Applicant's remaining arguments will also be addressed below.

With respect to applicant's argument that the SiN coating is formed on the SiO2 dielectric and not on the recording layer 3002, this argument is not persuasive because in the same embodiment discussed above Knight discloses wherein the structure would place the SiN recording layer directly on the recording layer (col. 37 line 12). The structure disclosed is SiN/Mo/(SiOx/SiN)/Al/Substrate which reads on the claim.

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With respect to applicant's argument that the references fail to show a motivation to combine, this argument is not persuasive because Knight clearly discloses that any write-once, or phase change material can be used as the recording layer (col. 29 lines 49-67), and Okubo discloses using Silicon as a suitable write-once recording layer. The argument that the combination of Okubo and Knight would not function lacks any evidence or reasoning as to why the combination would not function. Applicant asserts that the thickness of the substrate in Okubo would cause the combination not to function, however, nowhere in Okubo does the reference limit the use of a Silicon recording layer to a particular thickness of substrate, and Okubo even discloses wherein the substrate thickness is variable from .3 mm to 1.2 mm (par. 72). Finally, applicant's argument that Okubo's disclosure of placing the Si layer directly on the substrate as the most desirable structure because of its simplicity is a showing of the reference teaching away is not persuasive for two reasons. First Okubo's disclosure that the particular structure is desirable due to simplicity does not teach away from a different structure, and does not show that a different structure may not also be desirable and feasible. Secondly, the references are only combined to show that the Silicon can be used as a suitable recording layer, and the structure of the disk is fully disclosed in Knight.

## Conclusion

Since the examiner has changed his position with respect to the disclosure in the previously cited references, this action is a Non-Final rejection.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Tawfik Goma whose telephone number is (571) 272-4206. The examiner can normally be reached on 8:30 am - 5:00 pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, William Korzuch can be reached on (571) 272-7589. The fax phone number

for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the

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800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Tawfik Goma/

T. Goma

5/10/2007

WILLIAM KORZUCH SUPERVISORY PATENT EXAMINER

TECHNOLOGY CENTER 2600